Notice of References Cited

Application/Control No.	Applicant(s)/Pater	nt Under
10/814,729	Reexamination NGUYEN ET AL.	
Examiner	Art Unit	
Xavier Szewai Wong	2416	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2007/0204036 A1	08-2007	Mohaban et al.	709/224
*	В	US-7,002,974 B1	02-2006	Deerman et al.	370/401
*	С	US-2003/0223361 A1	12-2003	Hussain et al.	370/230
*	D	US-2005/0111360 A1	05-2005	Jin et al.	370/229
*	Е	US-2003/0214905 A1	11-2003	Solomon et al.	370/229
*	F	US-2006/0209796 A1	09-2006	Scott, Mark	370/352
*	G	US-6,798,746 B1	09-2004	Kloth et al.	370/235
*	Н	US-2002/0103925 A1	08-2002	Sheth et al.	709/236
*	Т	US-7,463,628 B1	12-2008	Parker et al.	370/392
*	J	US-7,292,591 B1	11-2007	Parker et al.	370/401
*	к	US-2005/0117576 A1	06-2005	McDysan et al.	370/389
	L	US-			
	м	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
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	Т					

NON-PATENT DOCUMENTS

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	w						
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A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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